



## **INSTITUTE OF NANO OPTOELECTRONICS RESEARCH AND TECHNOLOGY (INOR)**

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## **CHARACTERIZATION ANALYSIS REQUEST FORM**

Requestor Name	:		
Contact No.	: Ema	iil :	Date :
School/Company	:		
Category	: INOR Staff/Student	Other Dept. :	
Sample Type	: Powder Thin Film		ple :
Materials	<u> </u>		
Substrate	:		
Please Tick Appropriate Box		QUIPMENT	
	73		
Photoluminescer		Probe Station with Micro-Po	
Spectrum range:	nm to nm	CV IV With Sample Prep	Uthers Without Sample Prep
Electroluminesce	ence [EL]	Contact:	Without outling triep
	ge Fix V= limit	Ohmic	
	ge Fix I = limit	Schottky	
		Metal :	
		Thickness :	
Other information a	about the sample (e.g. sample stability/temperat	ure):	
Requestor Signatur	re:	Supervisor Approval:	
Noqueote: Oignata.	<b>C.</b>	(if Students, need to get the approval from Superv	risor)

- Remarks:

  \* Please refer to the analysis/equipment usage charges on INOR website.

  \*\* Any incomplete form will not be processed.

  \*\*\* Quotation will be sent through requestor's email within 3 working days.